Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | WANG ET AL. | Examiner | Art Unit | Nathan W. Ha | 2814 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	UȘ-2004/0063277 A1	04-2004	Chudzik et al.	438/243
	В	US-2004/0147074 A1	07-2004	Sell et al.	438/243
	С	US-2004/0188739 A1	09-2004	Takenaka et al.	257/301
	D	US-6,777,303 B2	08-2004	Schrems et al.	438/386
	E	US-6,211,006 B1	04-2001	Tsai et al.	438/246
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			:
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q	·				
	R					
:	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.